

# AO3404A

# **N-Channel Enhancement Mode Field Effect Transistor**

# **General Description**

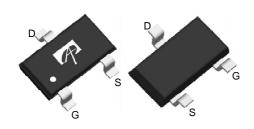
The AO3404A uses advanced trench technology to provide excellent  $R_{\text{DS(ON)}}$  and low gate charge. This device is suitable for use as a load switch or in PWM applications. The source leads are separated to allow a Kelvin connection to the source, which may be used to bypass the source inductance.

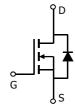
## **Features**

$$\begin{split} &V_{DS}\left(V\right) = 30V \\ &I_{D} = 5.8A & (V_{GS} = 10V) \\ &R_{DS(ON)} < 25m\Omega & (V_{GS} = 10V) \\ &R_{DS(ON)} < 35m\Omega & (V_{GS} = 4.5V) \end{split}$$



SOT23
Top View Bottom View





Absolute Maximum Ratings T<sub>A</sub>=25℃ unless otherwise noted

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V <sub>DS</sub>	30	V	
Gate-Source Voltage		$V_{GS}$	±20	V	
Continuous Drain	T <sub>A</sub> =25℃		5.8		
Current A,F	T <sub>A</sub> =70℃	I <sub>D</sub>	4.9	A	
Pulsed Drain Current <sup>B</sup>		I <sub>DM</sub>	64	1	
	T <sub>A</sub> =25℃	Р	1.4	W	
Power Dissipation	T <sub>A</sub> =70℃	$-P_{D}$	0.9		
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	C	

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta JA}$	65	90	℃/W			
Maximum Junction-to-Ambient A	Steady-State	IN <sub>θ</sub> JA	85	125	°C/W			
Maximum Junction-to-Lead <sup>C</sup>	Steady-State	$R_{\theta JL}$	63	80	℃/W			

#### Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units				
STATIC PARAMETERS										
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V	30			V				
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V			1	μΑ				
		T <sub>J</sub> =55℃			5	p				
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ = ±20V			100	nA				
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_{D}=250\mu A$	1.5	2.1	2.6	V				
$I_{D(ON)}$	On state drain current	$V_{GS}$ =4.5V, $V_{DS}$ =5V	64			Α				
		V <sub>GS</sub> =10V, I <sub>D</sub> =5.8A		18.4	25	mΩ				
$R_{DS(ON)}$	Static Drain-Source On-Resistance	T <sub>J</sub> =125℃		26.2	36	11132				
		$V_{GS}$ =4.5V, $I_{D}$ =4.8A		24.5	35	$m\Omega$				
g <sub>FS</sub>	Forward Transconductance	VDS=5V, ID=5.8A		22		S				
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A,V <sub>GS</sub> =0V		0.75	1	V				
Is	Maximum Body-Diode Continuous Curr			2.5	Α					
DYNAMIC	PARAMETERS		•		•	•				
C <sub>iss</sub>	Input Capacitance			373	448	pF				
C <sub>oss</sub>	Output Capacitance	$V_{GS}$ =0V, $V_{DS}$ =15V, f=1MHz		67		pF				
C <sub>rss</sub>	Reverse Transfer Capacitance			41		pF				
$R_g$	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz		1.8	2.8	Ω				
SWITCHI	NG PARAMETERS									
Q <sub>g</sub> (10V)	Total Gate Charge			7.1	11	nC				
Q <sub>g</sub> (4.5V)	Total Gate Charge	VGS=10V, VDS=15V, ID=5.8A		3.3		nC				
$Q_{gs}$	Gate Source Charge	- VGS=10V, VDS=15V, ID=5.6A		1.4		nC				
$Q_{gd}$	Gate Drain Charge	7		1.7		nC				
t <sub>D(on)</sub>	Turn-On DelayTime			4.5	6.5	ns				
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =15V, $R_{L}$ =2.6 $\Omega$ ,		2.4		ns				
t <sub>D(off)</sub>	Turn-Off DelayTime	$R_{GEN}=3\Omega$		14.8		ns				
t <sub>f</sub>	Turn-Off Fall Time	1		2.5		ns				
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =5.8A, dI/dt=100A/μs		10.5	12.6	ns				
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =5.8A, dI/dt=100A/μs		4.5		nC				

A: The value of R  $_{\theta JA}$  is measured with the device mounted on 1 in  $^2$  FR-4 board with 2 oz. Copper, in a still air environment with T  $_A$ =25 $^\circ$  C. The value in any given application depends on the user's specific board design. The current rating is based on the t  $\, \leq \,$  10s thermal resistance rating.

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B: Repetitive rating, pulse width limited by junction temperature.

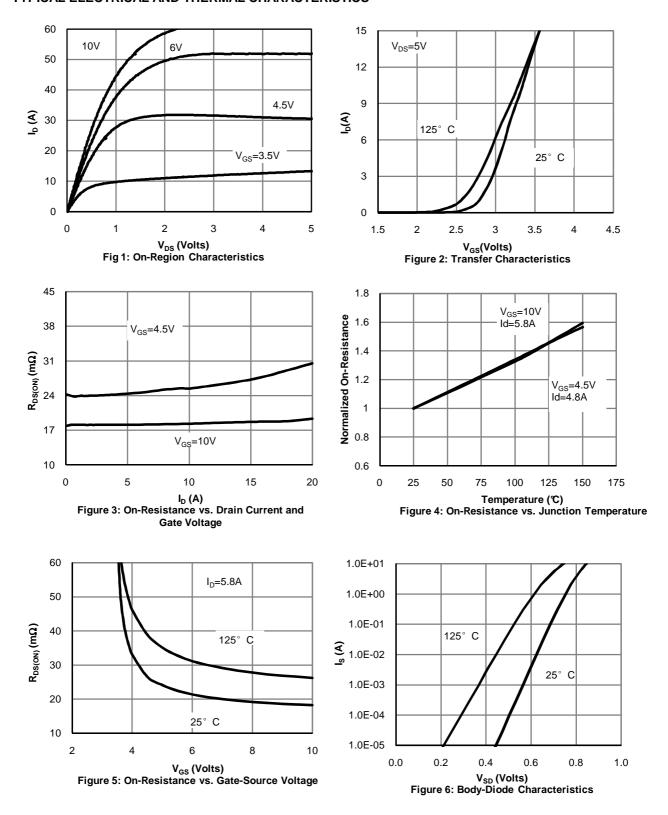
C. The R  $_{\theta JA}$  is the sum of the thermal impedence from junction to lead R  $_{\theta JL}$  and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using <300 µs pulses, duty cycle 0.5% max.

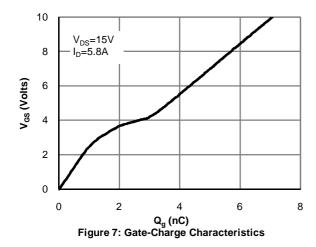
E. These tests are performed with the device mounted on 1 in <sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C. The SOA curve provides a single pulse rating.

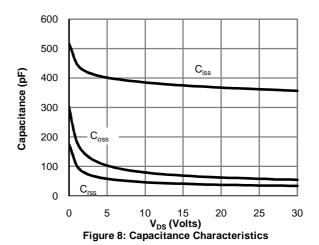
F.The current rating is based on the t≤ 10s thermal resistance rating.

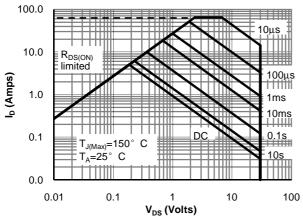
## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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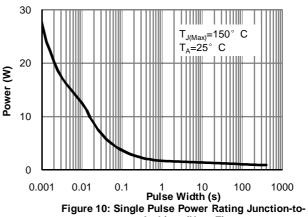
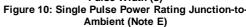


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)



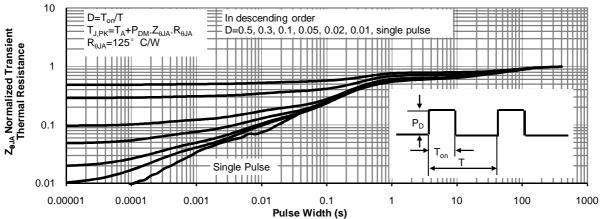


Figure 11: Normalized Maximum Transient Thermal Impedance